

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10553604	LONG ET AL.
	Examiner	Art Unit
	Phu K Nguyen	2628

SEARCHED

Class	Subclass	Date	Examiner
345	419, 421, 422, 427, 428, 619, 629	3/15/08	pn
Update	searches	6/12/08	pn

SEARCH NOTES

Search Notes	Date	Examiner
WEST search: scan, depth, fill, texture, span, segment	3/15/08	pn
NonPatent Literature: IEEE, ACM, Google	3/15/08	pn
Inventor Name search	3/15/08	pn
Update searches	6/12/08	pn
Interference search in Pre-Published WEST	6/12/08	pn

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
345	421, 428	6/12/08	pn